30V N-Channel PowerTrench[®] MOSFET

General Description

FAIRCHILD SEMICONDUCTOR

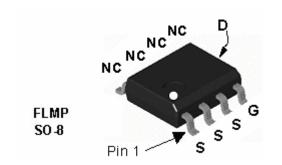
This N-Channel MOSFET has been designed specifically to improve the overall efficiency of DC/DC converters using either synchronous or conventional switching PWM controllers. It has been optimized for "low side" synchronous rectifier operation, providing an extremely low $R_{DS(ON)}$ in a small package.

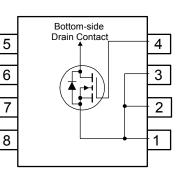
Applications

- Synchronous rectifier
- DC/DC converter

Features

- 21 A, 30 V $R_{DS(ON)} = 4 \text{ m}\Omega \textcircled{0} V_{GS} = 10 \text{ V}$ $R_{DS(ON)} = 5 \text{ m}\Omega \textcircled{0} V_{GS} = 4.5 \text{ V}$
- High performance trench technology for extremely low $R_{\text{DS}(\text{ON})}$
- High power and current handling capability
- Fast switching
- FLMP SO-8 package: Enhanced thermal performance in industry-standard package size





Absolute Maximum Ratings T_A=25°C unless otherwise noted

Symbol	Parameter		Ratings	Units
V _{DSS}	Drain-Source Voltage		30	V
V _{GSS}	Gate-Source Voltage		±20	
I _D	Drain Current – Continuous	(Note 1a)	21	А
	– Pulsed		60	
P _D	Power Dissipation for Single Operation	(Note 1a)	3.0	W
		(Note 1b)	1.5	
T _J , T _{STG}	Operating and Storage Junction Temperatu	ure Range	–55 to +150	°C
Therma	I Characteristics	·		
	Thermal Resistance, Junction-to-Ambient (Note 1a)		40	°C/W
$R_{ ext{ heta}JA}$	Thermal Resistance, Junction-to-Ambient	(Note Ta)	40	C/VV

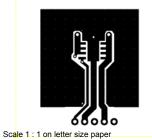
Device Marking	Device	Reel Size	Tape width	Quantity
FDS7088N3	FDS7088N3 FDS7088N3 13"		12mm	2500 units

©2004 Fairchild Semiconductor Corporation

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Chara	acteristics					
BV _{DSS}	Drain–Source Breakdown Voltage	$V_{GS} = 0 V$, $I_D = 250 \mu A$	30			V
<u>ΔBVdss</u> ΔTj	Breakdown Voltage Temperature Coefficient	I_D = 250 µA, Referenced to 25°C		25		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 24 V$, $V_{GS} = 0 V$			10	μA
I _{GSS}	Gate–Body Leakage	V_{GS} = ±20 V, V_{DS} = 0 V			±100	nA
On Chara	acteristics (Note 2)					
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, \qquad I_D = 250 \ \mu A$	1	1.9	3	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate Threshold Voltage Temperature Coefficient	I_D = 250 µA, Referenced to 25°C		-6		mV/°C
R _{DS(on)}	Static Drain–Source On–Resistance			3.0 3.7 4.4	4 5 5.5	mΩ
g _{FS}	Forward Transconductance	$V_{DS} = 10 V$, $I_{D} = 21 A$		112		S
Dynamic	Characteristics					
C _{iss}	Input Capacitance	$V_{DS} = 15 V$, $V_{GS} = 0 V$,		3845		pF
C _{oss}	Output Capacitance	f = 1.0 MHz		930		pF
C _{rss}	Reverse Transfer Capacitance	7		368		pF
R _G	Gate Resistance	V _{GS} = 15 mV, f = 1.0 MHz		1.4		Ω
Switchin	g Characteristics (Note 2)					
t _{d(on)}	Turn–On Delay Time	$V_{DD} = 15 V$, $I_D = 1 A$,	1	15	27	ns
t _r	Turn–On Rise Time	$V_{GS} = 10 \text{ V}, \qquad R_{GEN} = 6 \Omega$		13	23	ns
t _{d(off)}	Turn–Off Delay Time	7		62	99	ns
t _f	Turn–Off Fall Time	7		36	58	ns
Qg	Total Gate Charge	$V_{DS} = 15 V$, $I_D = 21 A$,		37	48	nC
Q _{gs}	Gate-Source Charge	V _{GS} = 5.0 V		10		nC
Q _{gd}	Gate–Drain Charge	1		14		nC
Drain-So	ource Diode Characteristics	and Maximum Ratings				
ls	Maximum Continuous Drain-Sourc				2.5	Α
V _{SD}	Drain–Source Diode Forward Voltage	$V_{GS} = 0 V$, $I_S = 2.5 A$ (Note 2)		0.7	1.2	V
t _{rr}	Diode Reverse Recovery Time	I _F = 21 A,		39		nS
Q _{rr}	Diode Reverse Recovery Charge	d _{iF} /d _t = 100 A/µs		33		nC

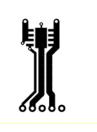
Notes:

1. R_{8JA} is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. R_{8JC} is guaranteed by design while R_{8CA} is determined by the user's board design.



2. Pulse Test: Pulse Width < 300 $\mu s,$ Duty Cycle < 2.0 %

a) 40°C/W when mounted on a 1in² pad of 2 oz copper

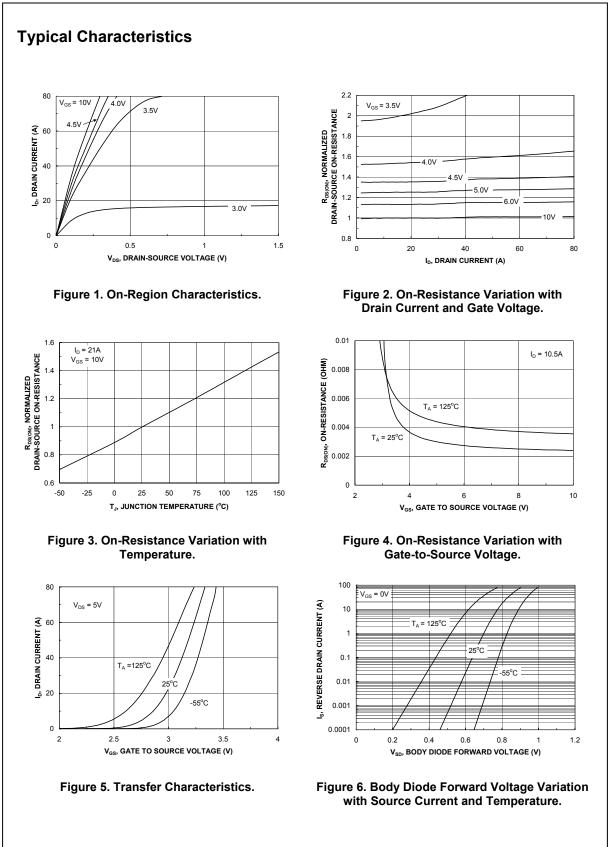


85°C/W when mounted on a minimum pad of 2 oz copper

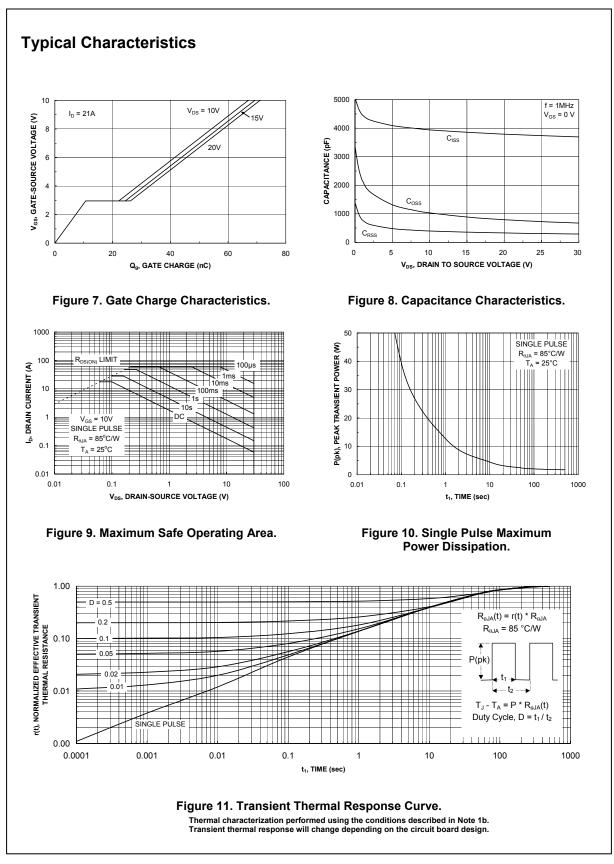
b)

FDS7088N3 Rev D1 (W)

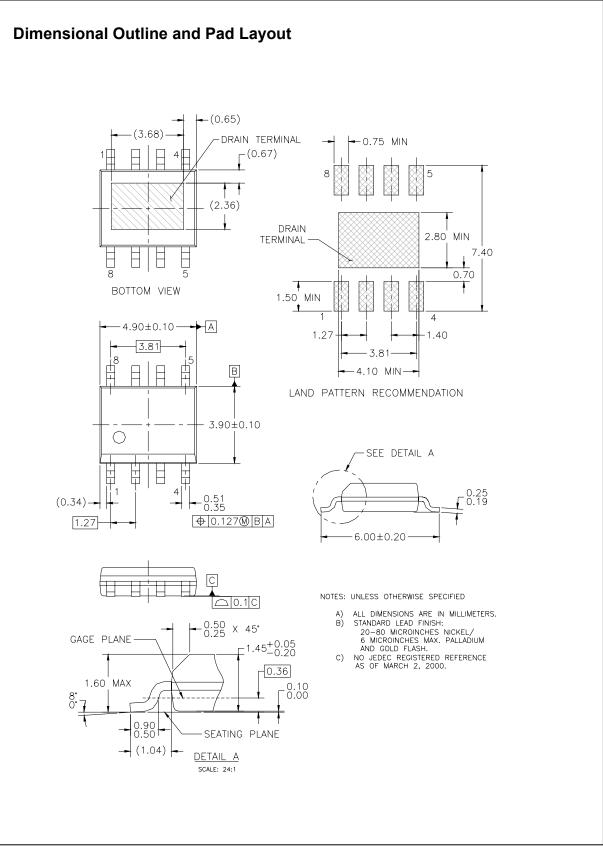
FDS7088N3



FDS7088N3 Rev D1 (W)



FDS7088N3 Rev D1 (W)



FDS7088N3 Rev D1 (W)

TRADEMARKS

The following are registered and unregistered trademarks Fairchild Semiconductor owns or is authorized to use and is not intended to be an exhaustive list of all such trademarks.

ACEx™	FACT Quiet Series™	ISOPLANAR™	POP™	Stealth™
ActiveArray™	FAST®	LittleFET™	Power247™	SuperFET™
Bottomless™	FASTr™	MICROCOUPLER™	PowerSaver™	SuperSOT [™] -3
CoolFET™	FPS™	MicroFET™	PowerTrench [®]	SuperSOT [™] -6
CROSSVOLT™	FRFET™	MicroPak™	QFET [®]	SuperSOT [™] -8
DOME™	GlobalOptoisolator™	MICROWIRE™	QS™	SyncFET™
EcoSPARK™	GTO™່	MSX™	QT Optoelectronics [™]	TinyLogic [®]
E ² CMOS [™]	HiSeC™	MSXPro™	Quiet Series [™]	TINYOPTO™
EnSigna™	I ² C [™]	OCX™	RapidConfigure™	TruTranslation™
FACT™	ImpliedDisconnect [™]	OCXPro™	RapidConnect™	UHC™
Across the boar	d. Around the world.™	OPTOLOGIC [®]	SILENT SWITCHER®	UltraFET [®]
The Power Fran		OPTOPLANAR™	SMART START™	VCX™
Programmable A		PACMAN™	SPM™	

DISCLAIMER

FAIRCHILD SEMICONDUCTOR RESERVES THE RIGHT TO MAKE CHANGES WITHOUT FURTHER NOTICE TO ANY PRODUCTS HEREIN TO IMPROVE RELIABILITY, FUNCTION OR DESIGN. FAIRCHILD DOES NOT ASSUME ANY LIABILITY ARISING OUT OF THE APPLICATION OR USE OF ANY PRODUCT OR CIRCUIT DESCRIBED HEREIN; NEITHER DOES IT CONVEY ANY LICENSE UNDER ITS PATENT RIGHTS, NOR THE RIGHTS OF OTHERS.

LIFE SUPPORT POLICY

FAIRCHILD'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS WRITTEN APPROVAL OF FAIRCHILD SEMICONDUCTOR CORPORATION. As used herein:

1. Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body, or (b) support or sustain life, or (c) whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in significant injury to the user.

2. A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

PRODUCT STATUS DEFINITIONS

Definition of Terms

Product Status	Definition
Formative or In Design	This datasheet contains the design specifications for product development. Specifications may change in any manner without notice.
First Production	This datasheet contains preliminary data, and supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.
Full Production	This datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.
Not In Production	This datasheet contains specifications on a product that has been discontinued by Fairchild semiconductor. The datasheet is printed for reference information only.
	Formative or In Design First Production Full Production